



FORM PTO-1449 (modified)
To: U.S. Department of Commerce
(PW FORM PAT-1449)
Patent and Trademark Office

Atty. Dkt. No.	M#	Client Ref.
	044182	308725

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: Raymond H. Kraft	
Appln. No.: 10/800,421	
Filing Date: March 12, 2004	
Examiner:	Group Art Unit: 2857

Date: October 13, 2004

Page 1 of 1

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
JLR	ER	EP 1061381 A2	12/2000	EPO	Strom	X		X	
	FR								
	GR								
	HR								
	IR								
	JR								

OTHER (Including in this order: Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

JLR	KR	WANG, Y.; Lawrence H. Staib; "Physical Model-based non-rigid registration incorporating statistical shape information" Medical Image Analysis, Vol. 4, No. 1, 2000, pp. 7-20	X		X	
JLR	LR	BESL, Paul J., and Neil D. McKay, "A method for registration of 3-D shapes" IEEE Transactions on Pattern Analysis and Machine Intelligence, IEEE Inc., New York, U.S., Vol. 14, No. 2, February 1, 1992, 0pp. 239-256	X		X	
JLR	MR	RANGARAJAN, Anand, Hali Chui and Eric Mjolsness, "A new distance for non-rigid image matching" 1999, Berlin, Germany, pp. 237-252	X		X	
JLR	NR	CACHIER, Pascal, and Xavier Pennec "3D Non-Rigid Registration by Gradient Descent on a Gaussian-Windowed Similarity Measure Using Convolutions" IEEE Comput. Soc. U.S.A., June 2000, pp. 182-189	X		X	
	OR					
	PR					

Examiner: *JLR* Date Considered: 6/10/05

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.